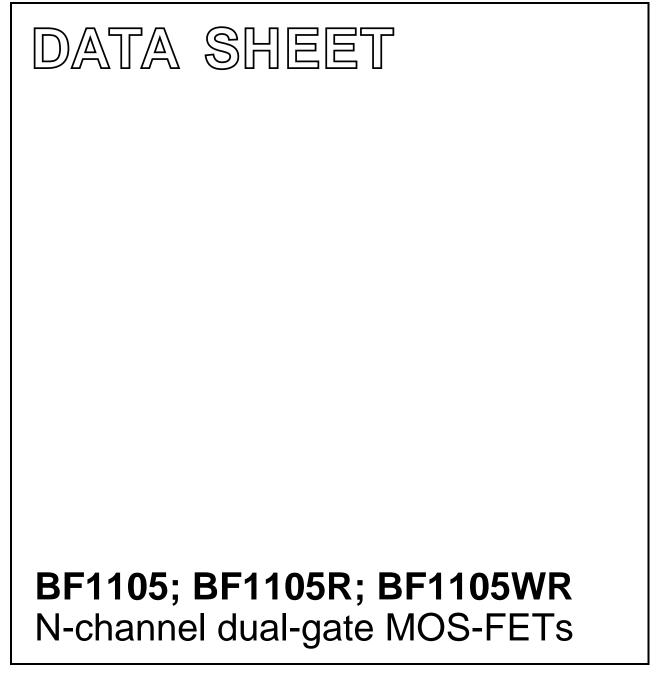
DISCRETE SEMICONDUCTORS



Product specification Supersedes data of 1997 Dec 01 1997 Dec 02



MSB035

N-channel dual-gate MOS-FETs

FEATURES

PINNING

3

4

- · Short channel transistor with high forward transfer admittance to input capacitance ratio
- · Low noise gain controlled amplifier up to 1 GHz.
- Internal self-biasing circuit to ensure good cross-modulation performance during AGC and good DC stabilization.

APPLICATIONS

• VHF and UHF applications with 5 V supply voltage, such as television tuners and professional communications equipment.

DESCRIPTION

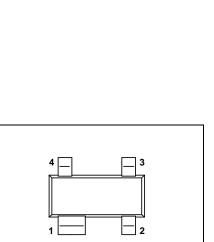
Enhancement type N-channel field-effect transistor with source and substrate interconnected. Integrated diodes between gates and source protect against excessive input voltage surges. The BF1105, BF1105R and BF1105WR are encapsulated in the SOT143B, SOT143R and SOT343R plastic packages respectively.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{DS}	drain-source voltage		_	-	7	V
I _D	drain current		_	-	30	mA
P _{tot}	total power dissipation	$T_{amb} \le 80 \ ^{\circ}C$	_	-	200	mW
y _{fs}	forward transfer admittance		25	31	_	mS
C _{ig1-ss}	input capacitance at gate 1		-	2.2	2.7	pF
C _{rss}	reverse transfer capacitance	f = 1 MHz	-	25	40	fF
F	noise figure	f = 800 MHz	_	1.7	2.5	dB
X _{mod}	cross-modulation	input level for k = 1% at 40 dB AGC	100	-	_	dBµV
Tj	operating junction temperature		-	-	150	°C

CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling.



MSB014

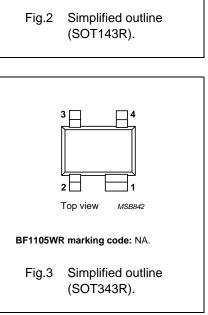
Simplified outline

(SOT143B).

Top view

Fig.1

BF1105 marking code: NEp.



PIN DESCRIPTION 1 source 2 drain

gate 2

gate 1

BF1105; BF1105R; **BF1105WR**

3

Top view

BF1105R marking code: NAp.

BF1105; BF1105R; BF1105WR

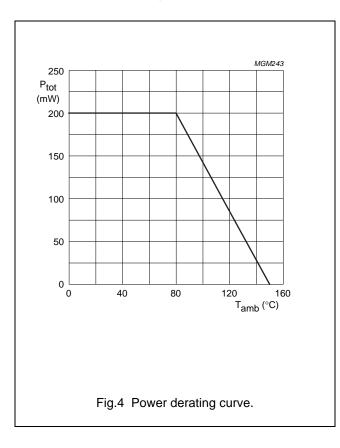
LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DS}	drain-source voltage		-	7	V
I _D	drain current		-	30	mA
I _{G1}	gate 1 current		-	±10	mA
I _{G2}	gate 2 current		-	±10	mA
P _{tot}	total power dissipation	$T_{amb} \le 80 \ ^{\circ}C$; note 1; see Fig.4	-	200	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	operating junction temperature		_	+150	°C

Note

1. Device mounted on a printed-circuit board.



BF1105; BF1105R; BF1105WR

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-a}	thermal resistance from junction to ambient in free air	note 1	350	K/W
R _{th j-s}	thermal resistance from junction to soldering point		200	K/W

Note

1. Device mounted on a printed-circuit board.

STATIC CHARACTERISTICS

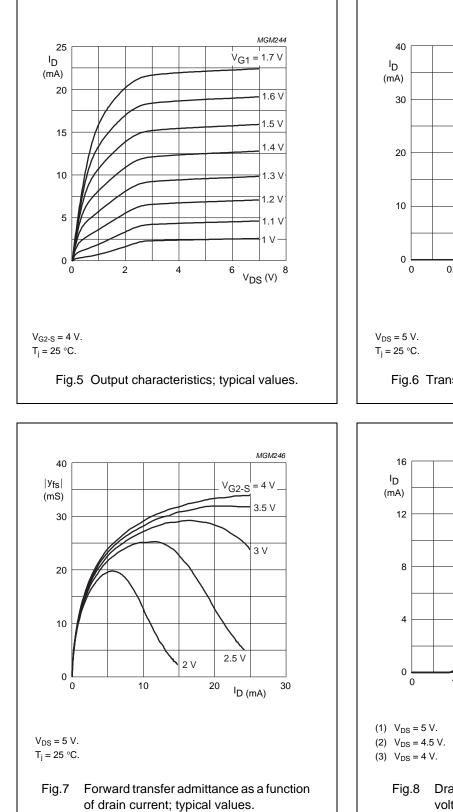
 $T_j = 25 \ ^{\circ}C$ unless otherwise specified.

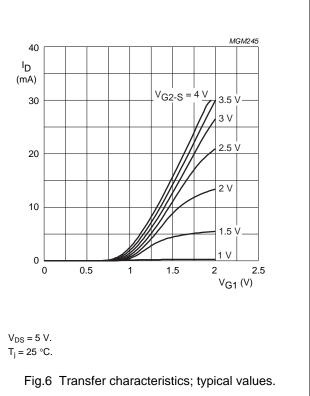
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{(BR)DSS}	drain-source breakdown voltage	$V_{G1-S} = V_{G2-S} = 0; I_D = 10 \ \mu A$	7	_	_	V
V _{(BR)G1-SS}	gate 1-source breakdown voltage	$V_{G2-S} = 0; I_D = 0; I_{G1-S} = 10 \ \mu A$	7	_	_	V
V _{(BR)G2-SS}	gate 2-source breakdown voltage	$V_{G1-S} = V_{DS} = 0; I_{G2-S} = 10 \ \mu A$	7	_	_	V
V _{G2-S (th)}	gate 2-source threshold voltage	$V_{G1-S} = 5 \text{ V}; V_{DS} = 5 \text{ V}; I_D = 20 \mu\text{A}$	0.3	0.8	1.2	V
I _{DSX}	self-biasing drain current	$V_{G2-S} = 4 V; V_{DS} = 5 V$	8	-	16	mA
I _{G1-SS}	gate 1 cut-off current	$V_{G1-S} = 5 V; V_{G2-S} = 0; I_D = 0$	-	_	50	nA
I _{G2-SS}	gate 2 cut-off current	$V_{G1-S} = V_{DS} = 0; V_{G2-S} = 4 V$	-	_	20	nA

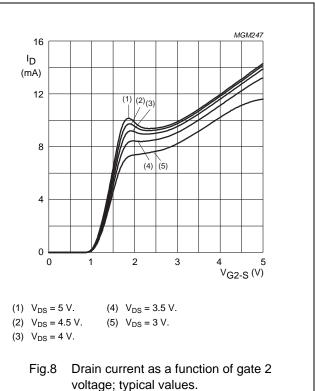
DYNAMIC CHARACTERISTICS

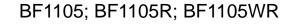
Common source; T_{amb} = 25 °C; V_{G2-S} = 4 V; V_{DS} = 5 V; self-biasing current; unless otherwise specified.

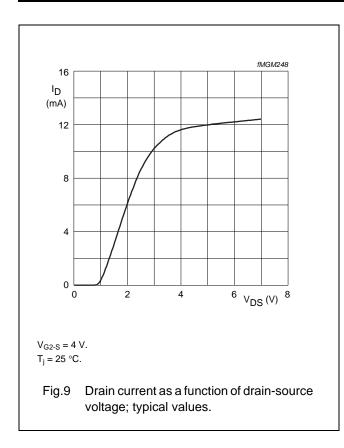
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
y _{fs}	forward transfer admittance	pulsed; T _j = 25 °C	25	31	-	mS
C _{ig1-ss}	input capacitance at gate 1	f = 1 MHz	-	2.2	2.7	pF
C _{ig2-ss}	input capacitance at gate 2	f = 1 MHz	-	1.6	_	pF
C _{oss}	output capacitance	f = 1 MHz	-	1.2	-	pF
C _{rss}	reverse transfer capacitance	f = 1 MHz	-	25	40	fF
F	noise figure	$f = 800 \text{ MHz}; Y_S = Y_S \text{ opt}$	-	1.7	2.5	dB
G _p	power gain	$G_{S} = 2 \text{ mS}; B_{S} = B_{S \text{ opt}}; G_{L} = 0.5 \text{ mS};$ $B_{L} = B_{L \text{ opt}}; f = 200 \text{ MHz}; \text{ see Fig.16}$	-	38	-	dB
		$G_S = 3.3 \text{ mS}; B_S = B_S \text{ opt}; G_L = 1 \text{ mS};$ $B_L = B_L \text{ opt}; f = 800 \text{ MHz}; \text{ see Fig.17}$	-	20	-	dB
X _{mod}	cross-modulation	input level for k = 1% at 0 dB AGC; $f_w = 50 \text{ MHz}$; $f_{unw} = 60 \text{ MHz}$; see Fig.18	85	-	_	dBμV
		input level for k = 1% at 40 dB AGC; $f_w = 50 \text{ MHz}$; $f_{unw} = 60 \text{ MHz}$; see Fig.18	100	-	-	dBμV

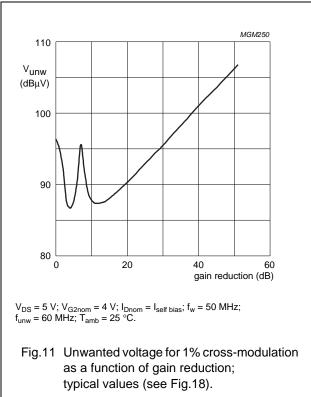












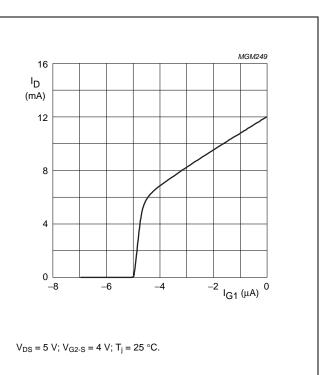
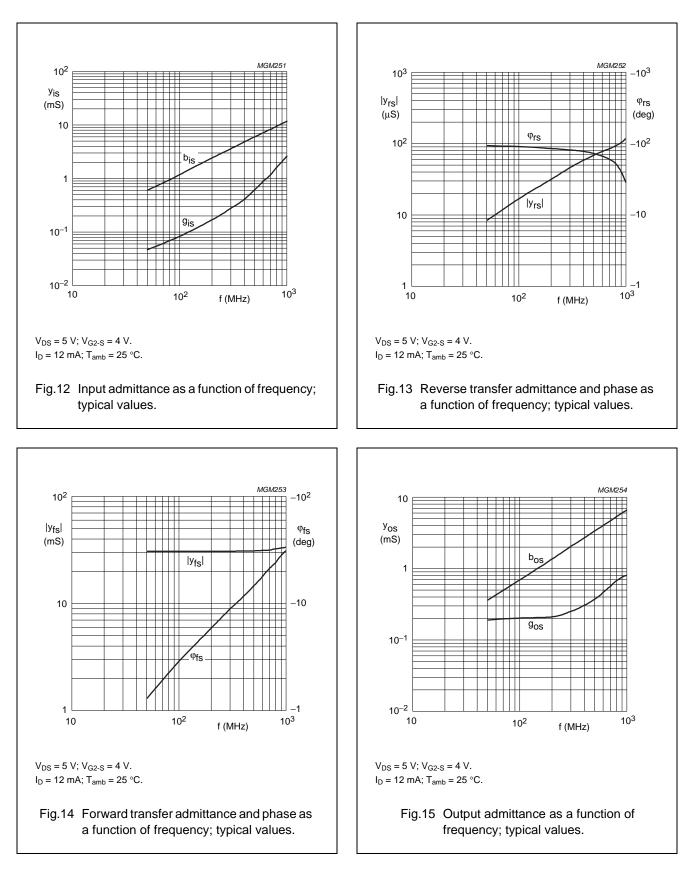
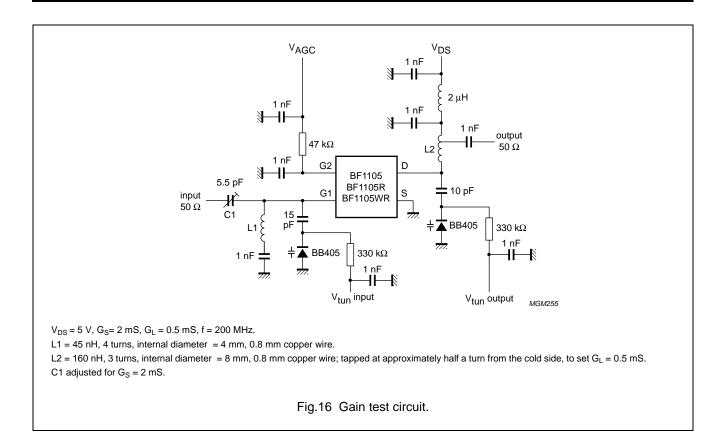
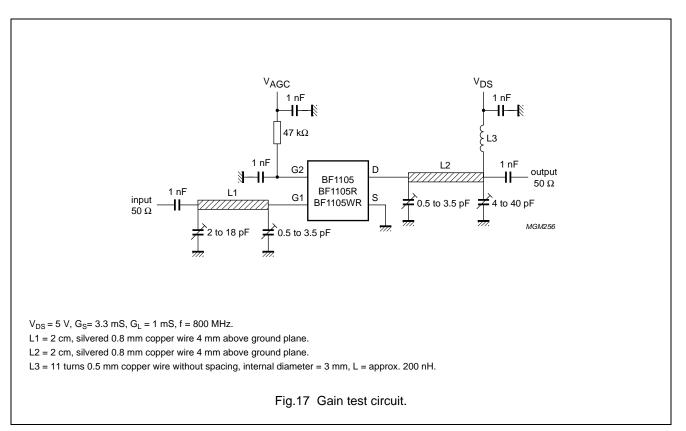


Fig.10 Drain current as a function of gate 1 current; typical values.







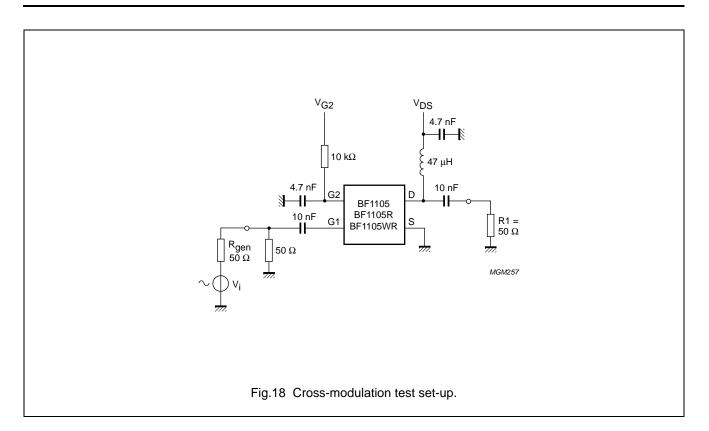


Table 1 S	Scattering parameters:	$V_{DS} = 5 V_{S}$; V _{G2-S} = 4	V; I _D = 12 mA
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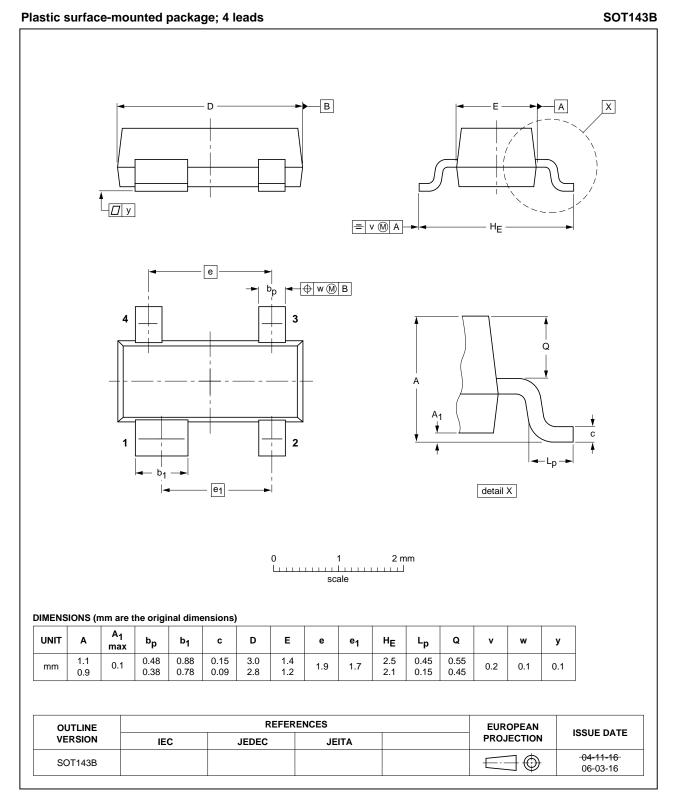
4	f S ₁₁		S ₂₁		S ₁₂		S ₂₂		
ı (MHz)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	
50	0.994	-3.8	3.060	175.4	0.000	86.9	0.985	-2.1	
100	0.991	-7.5	3.047	170.9	0.002	86.1	0.983	-4.2	
200	0.982	-14.7	3.004	162.1	0.003	82.7	0.980	-8.3	
300	0.968	-21.7	2.932	153.4	0.004	79.7	0.976	-12.1	
400	0.956	-28.8	2.896	145.3	0.006	77.8	0.972	-16.2	
500	0.937	-35.4	2.815	137.1	0.007	76.7	0.967	-20.0	
600	0.918	-41.8	2.735	129.2	0.007	76.3	0.961	-23.7	
700	0.897	-48.1	2.651	121.5	0.008	76.7	0.955	-27.3	
800	0.878	-54.0	2.575	114.0	0.008	79.7	0.948	-30.9	
900	0.858	-59.9	2.482	106.5	0.008	82.2	0.941	-34.4	
1000	0.840	-65.5	2.396	99.5	0.008	88.0	0.935	-37.9	

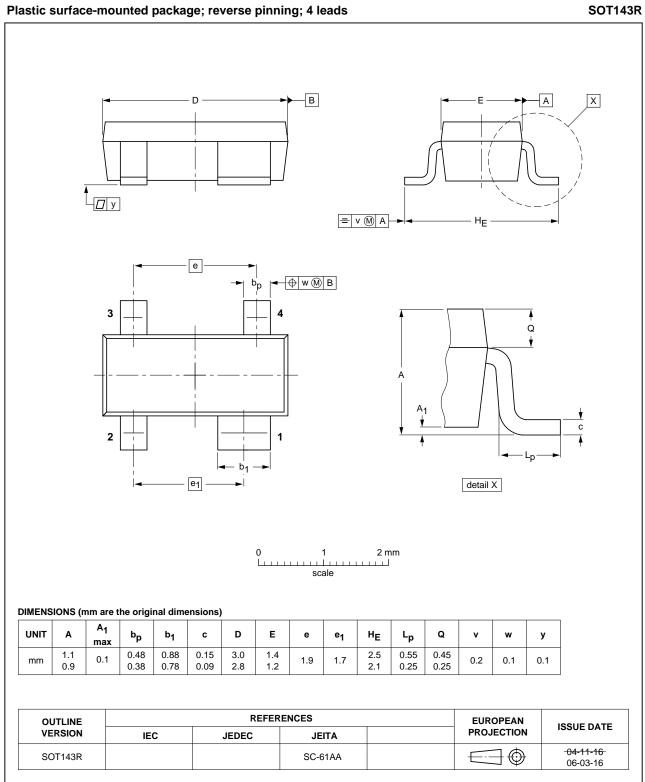
Table 2 Noise data: $V_{DS} = 5 V$; $V_{G2-S} = 4 V$; $I_D = 12 mA$

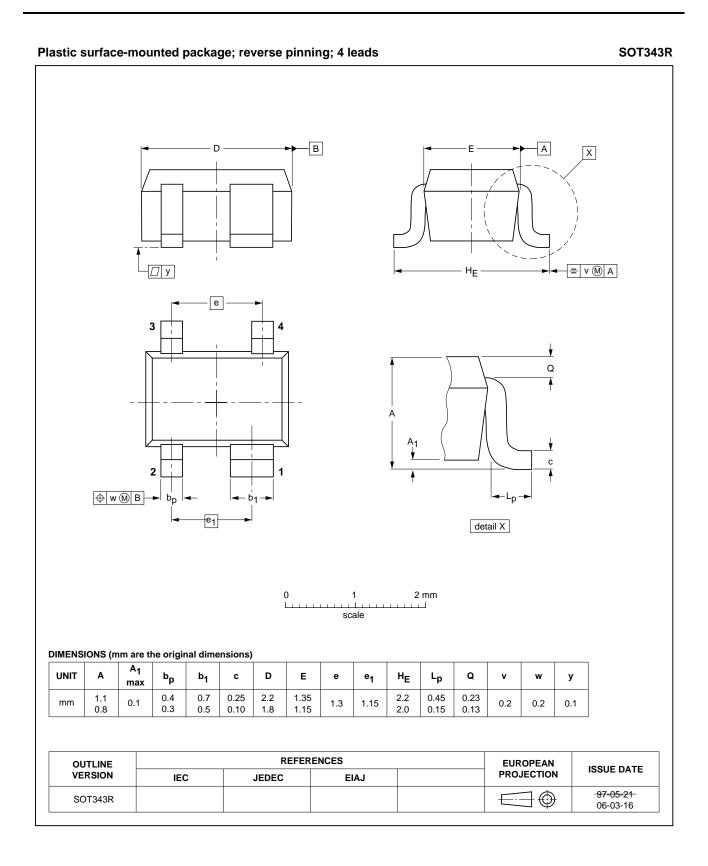
f	F _{min}	Г	opt	R _n
(MHz)	(dB)	(ratio)	(deg)	(Ω)
800	1.5	0.674	39.7	37.15

BF1105; BF1105R; BF1105WR

PACKAGE OUTLINES







BF1105; BF1105R; BF1105WR

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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BF1105; BF1105R; BF1105WR

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Printed in The Netherlands

R77/03/pp15

Date of release: 1997 Dec 02